

Notice of References Cited

Application/Control No.

10/550,003

Applicant(s)/Patent Under
Reexamination
FUJINE ET AL.

Examiner

PAULOS M. NATNAEL

Art Unit

2622

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,095,393	08-2006	Lee, Baek-Woon	345/89
*	B	US-6,707,439	03-2004	Ijima et al.	345/87
*	C	US-6,753,831	06-2004	Ide et al.	345/60
*	D	US-7,250,979	07-2007	Choi, Seung Jong	348/441
*	E	US-7,206,025	04-2007	Choi, Seung Jong	348/441
*	F	US-6,674,478	01-2004	Miyazaki et al.	348/441
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.